

LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY DOCKET NO. 100325.0208US	SERIAL NO. 10/555079
	APPLICANT John Mak et al.	
	FILING DATE 10/27/2005	GROUP UNKNOWN

U.S. PATENT DOCUMENTS

CLASSIFICATION	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE # APPROPRIATE
	AA 6,564,579	5/20/2003	McCartney	62	620	7/24/2002
	BB 3,837,172	9/24/1974	Markbreiter et al.	62	24	6/19/1972
	CC 5,114,451	5/19/1992	Rambo et al	62	24	3/12/1990
	DD 5,457,951	10/17/1995	Johnson et al.	60	39.02	2/14/1995
	EE 6,125,653	10/3/2000	Shu et al.	62	622	4/26/1999
	FF 4,456,459	6/26/1984	Brundage, Jr.	62	9	1/7/1983
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	HH 2003/0005658	1/9/2003	Keller	60	843	5/30/2002
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	JJ 4,121,817	10/24/1978	Baker et al.	62	28	10/6/1976

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	JJ						
	KK						
	LL						
	MM						

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc)

NN	
EXAMINER	/William Doerfler/
DATE CONSIDERED	04/10/2009
*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

2081/100325-0208US
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PAGE 5/5 * RCVD AT 1/26/2006 6:54:58 PM [Eastern Standard Time] * SVR:USPTO-EFEXRF-6/29 * DNIS:2738300 * CSID:714-546-9035 * DURATION (mm:ss):02:02

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /WD/